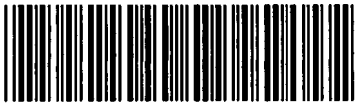


<b>Search Notes</b>  	<b>Application/Control No.</b>  10550102	<b>Applicant(s)/Patent Under Reexamination</b>  YOKOTAGAWA ET AL.
	<b>Examiner</b>  Niebauer, Ronald T	<b>Art Unit</b>  1654

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search in EAST, eDAN; STIC search on SEQ ID NO:1 (results in eDAN)	4/16/07	rtn
PubMed, EAST search	4/16/07	rtn
STN search (reg,capplus,biosis,medline) - see enclosed	9/5/07	rtn
updated inventor search in PALM, EAST	9/5/07	rtn
EAST search (uspat, uspgpub,osocr,fprs,epo,jpo,derwent) - see enclosed	9/5/07	rtn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner